# **Power MOSFET**

# 30 V, 3.9 A, Dual N-Channel ChipFET™

## **Features**

- $\bullet\,$  Planar Technology Device Offers Low  $R_{DS(on)}$  and Fast Switching Speed
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP-6. Ideal Device for Applications Where Board Space is at a Premium.
- ChipFET Package Exhibits Excellent Thermal Capabilities. Ideal for Applications Where Heat Transfer is Required.
- Pb-Free Package is Available

# **Applications**

- DC-DC Buck or Boost Converters
- Low Side Switching
- Optimized for Battery and Low Side Switching Applications in Computing and Portable Equipment

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parame	eter		Symbol	Value	Unit
Drain-to-Source Voltage	;		$V_{DSS}$	30	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	2.9	Α
Current (Note 1)	State	$T_A = 85^{\circ}C$		2.1	
	t ≤ 5 s	T <sub>A</sub> = 25°C		3.9	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.13	W
	t ≤ 5 s			2.1	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	2.2	Α
Current (Note 2)	Steady	T <sub>A</sub> = 85°C		1.6	
Power Dissipation (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.64	W
Pulsed Drain Current	t <sub>p</sub> =	= 10 μs	I <sub>DM</sub>	12	Α
ESD Capability (Note 3)	C = 100  pF, $R_S = 1500 \Omega$		ESD- HBM	125	V
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode)			I <sub>S</sub>	2.5	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

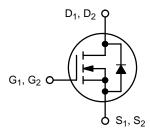
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).
- 3. ESD Rating Information: HBM Class 0.



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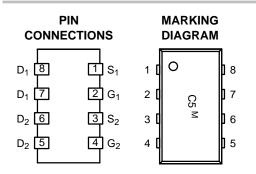
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
30 V	80 mΩ @ 10 V	3.9 A
30 V	110 mΩ @ 4.5 V	0.071



**N-Channel MOSFET** 



ChipFET CASE 1206A STYLE 2



C5 = Specific Device Code M = Month Code

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTHD4502NT1	ChipFET	3000/Tape & Reel
NTHD4502NT1G	ChipFET (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	110	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 4)	$R_{ heta JA}$	60	
Junction-to-Ambient - Steady State (Note 5)	$R_{ heta JA}$	195	

<sup>4.</sup> Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
5. Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
OFF CHARACTERISTICS			•	•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	36		V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V			1.0	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V, T <sub>J</sub> = 125°C			10	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.65	3.0	V
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 2.9 \text{ A}$		78	85	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 2.2 A		105	140	1
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 2.9 A		3.8		S
CHARGES AND CAPACITANCES	•			•		
Input Capacitance	C <sub>ISS</sub>			140		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 15 \text{ V}$		53		
Reverse Transfer Capacitance	C <sub>RSS</sub>			16		
Input Capacitance	C <sub>ISS</sub>			135	250	pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 24 \text{ V}$		42	75	1
Reverse Transfer Capacitance	C <sub>RSS</sub>	- 155 - 11		13	25	1
Total Gate Charge	Q <sub>G(TOT)</sub>			3.6	7.0	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	VGS = 10 V. VDS = 15 V.		0.3		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 2.9 \text{ A}$		0.6		
Gate-to-Drain Charge	Q <sub>GD</sub>	1		0.7		
Total Gate Charge	Q <sub>G(TOT)</sub>			1.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V, } V_{DS} = 24 \text{ V.}$		0.3		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 24 \text{ V},$ $I_{D} = 2.9 \text{ A}$		0.6		1
Gate-to-Drain Charge	$Q_{GD}$	1		0.9		1

<sup>6.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

# **ELECTRICAL CHARACTERISTICS (continued)** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACT	TERISTICS		•	•		
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V}, I_S = 2.5 \text{ A}$		0.85	1.2	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } I_{S} = 2.9 \text{ A,}$		8.6		ns
Reverse Recovery Charge	Q <sub>RR</sub>	$dI_S/dt = 100 A/\mu s$		4.0		nC
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.0 A,		8.4		ns
Reverse Recovery Charge	$Q_{RR}$	$dI_S/dt = 100 A/\mu s$		4.0		nC
SWITCHING CHARACTERISTICS (	Note 7)					
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 24 \text{ V},$ $I_{D} = 1 \text{ A}, R_{G} = 6 \Omega$		6.5	12	ns
Rise Time	t <sub>r</sub>			5.4	10	
Turn-Off Delay Time	t <sub>d(OFF)</sub>			14.9	25	
Fall Time	t <sub>f</sub>			1.8	5.0	
Turn-On Delay Time	t <sub>d(ON)</sub>			7.8		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DD} = 24 \text{ V},$		12.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 2.9 \text{ A}, R_G = 2.5 \Omega$		9.6		
Fall Time	t <sub>f</sub>			2.8		1

<sup>7.</sup> Switching characteristics are independent of operating junction temperatures.

## **TYPICAL PERFORMANCE CURVES**

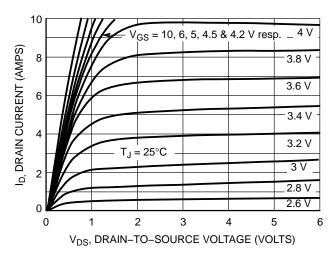


Figure 1. On-Region Characteristics

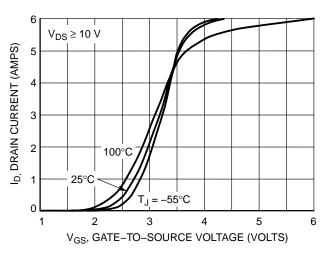


Figure 2. Transfer Characteristics

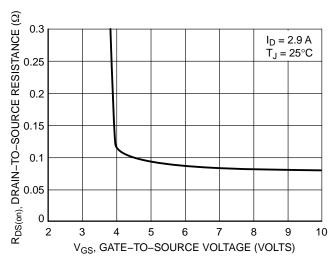


Figure 3. On-Resistance vs. Gate-to-Source Voltage

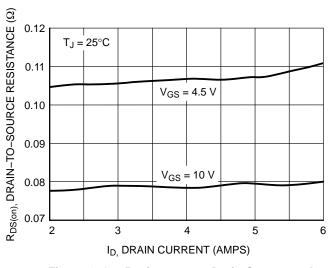


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

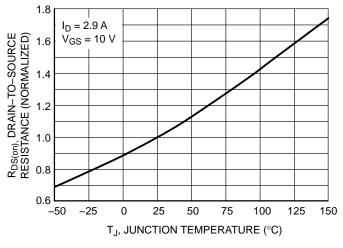


Figure 5. On–Resistance Variation with Temperature

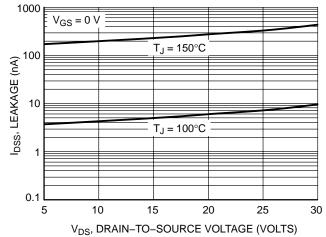
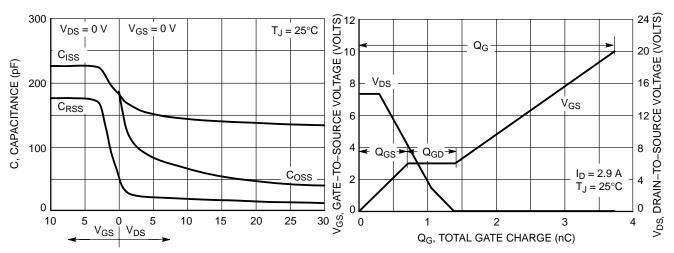


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

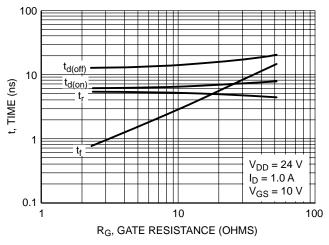


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

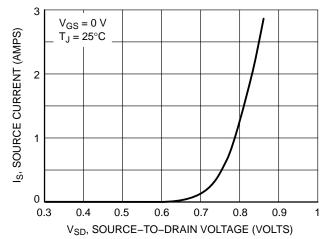
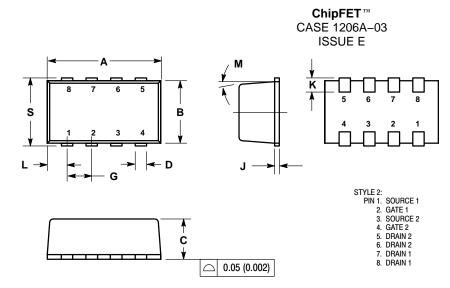


Figure 10. Diode Forward Voltage vs. Current

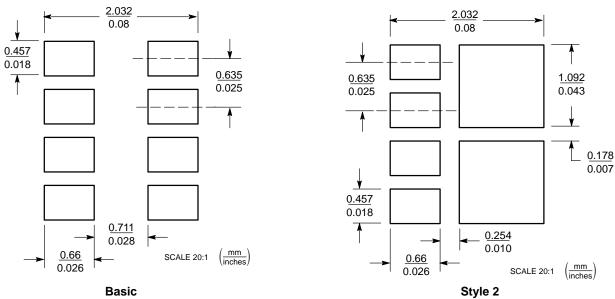
#### PACKAGE DIMENSIONS



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
- 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65	0.65 BSC		5 BSC	
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55 BSC		0.022 BSC		
M	5°	5° NOM		NOM	
S	1.80	2.00	0.072	0.080	

# **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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